

<b>Notice of References Cited</b>	Application/Control No. 10/525,488	Applicant(s)/Patent Under Reexamination GARG ET AL.	
	Examiner Ji H. Bae	Art Unit 2115	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,127,228	10-2006	Chang et al.	455/343.1
*	B	US-6,333,671	12-2001	Roberts et al.	327/544
*	C	US-6,212,641	04-2001	Frank et al.	713/323
*	D	US-6,661,279	12-2003	Yabe, Tomoaki	327/546
*	E	US-5,463,588	10-1995	Chonan, Toru	365/226
*	F	US-6,787,938	09-2004	McClure et al.	307/125
*	G	US-6,337,583	01-2002	Ooishi et al.	326/119
*	H	US-5,986,962	11-1999	Bertin et al.	365/228
*	I	US-5,204,963	04-1993	Noya et al.	365/229
*	J	US-4,683,382	07-1987	Sakurai et al.	327/544
*	K	US-5,784,548	07-1998	Liong et al.	714/6
*	L	US-6,762,638	07-2004	Correale et al.	327/202
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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